

TOSHIBA Bipolar Linear Integrated Circuit Silicon Monolithic

TA78M05SB,TA78M06SB,TA78M08SB,TA78M09SB,TA78M10SB, TA78M12SB,TA78M15SB,TA78M18SB,TA78M20SB,TA78M24SB

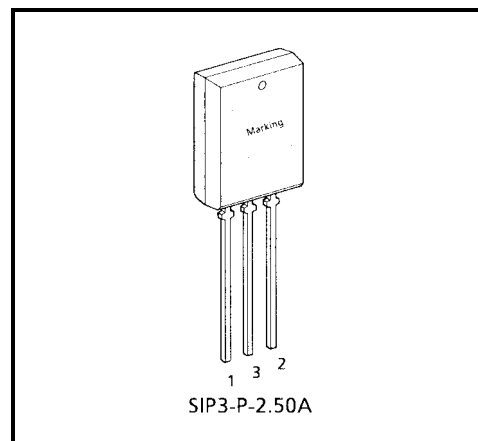
Output Current of 0.5 A, Three-Terminal Positive Voltage Regulators

5 V, 6 V, 8 V, 9 V, 10 V, 12 V, 15 V, 18 V, 20 V, 24 V

The TA78M××SB series of fixed-voltage monolithic integrated circuit voltage regulators is designed for a wide range of applications. These regulators employ internal current-limiting, thermal-shutdown and safe-area compensation, making them essentially indestructible. One of these regulators can driver up to 0.5 A of output current.

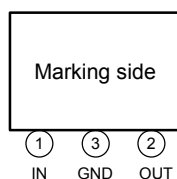
Features

- Suitable for CMOS, TTL and the other digital IC's power supply.
- Maximum output current of 0.5 A.
- Internal thermal overload protection.
- Internal short circuit current limiting.
- Package in the plastic case TPL (P_D = 1.8 W).

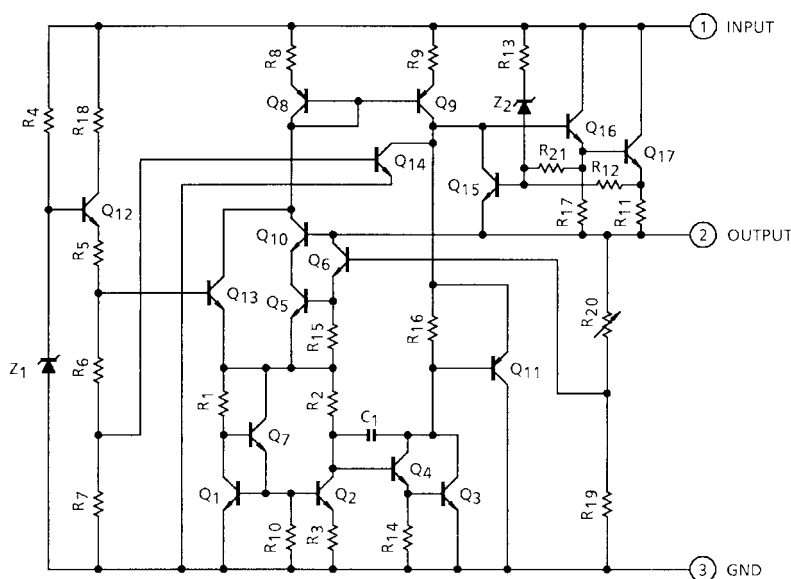


Weight: 1.5 g (Typ.)

Pin Assignment



Equivalent Circuit



Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit
Input voltage	TA78M05SB	V _{IN}	35	V
	TA78M06SB			
	TA78M08SB			
	TA78M09SB			
	TA78M10SB			
	TA78M12SB			
	TA78M15SB			
	TA78M18SB		40	
	TA78M20SB			
	TA78M24SB			
Power dissipation	(Ta = 25°C)	P _D	1.8	W
Operating temperature		T _{opr}	−30~85	°C
Storage temperature		T _{stg}	−55~150	°C
Junction temperature		T _j	150	°C
Thermal resistance		R _{th (j-a)}	69.4	°C/W

TA78M05SB
Electrical Characteristics

(Unless otherwise specified, $V_{IN} = 10\text{ V}$, $I_{OUT} = 350\text{ mA}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$)

Characteristics		Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage		V _{OUT}	1	T _j = 25°C		4.8	5.0	5.2	V
Line regulation		Reg-line	1	T _j = 25°C	7 V ≤ V _{IN} ≤ 25 V, I _{OUT} = 200 mA	—	4	100	mV
					8 V ≤ V _{IN} ≤ 25 V, I _{OUT} = 200 mA	—	2	50	
Load regulation		Reg-load	1	T _j = 25°C	5 mA ≤ I _{OUT} ≤ 500 mA	—	25	100	mV
					5 mA ≤ I _{OUT} ≤ 200 mA	—	10	50	
Output voltage		V _{OUT}	1	T _j = 25°C	7 V ≤ V _{IN} ≤ 20 V, 5 mA ≤ I _{OUT} ≤ 350 mA	4.75	—	5.25	V
Quiescent current		I _B	1	T _j = 25°C		—	4.5	8.0	mA
Quiescent current change	Line	ΔI _{BI}	1	T _j = 25°C	8.5 V ≤ V _{IN} ≤ 25.5 V, I _{OUT} = 200 mA	—	—	0.8	mA
	Load	ΔI _{BO}	1		5 mA ≤ I _{OUT} ≤ 350 mA	—	—	0.5	
Output noise voltage		V _{NO}	2	Ta = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	50	200	μV _{rms}
Ripple rejection		R.R.	3	f = 120 Hz, I _{OUT} = 100 mA, 8 V ≤ V _{IN} ≤ 18 V, T _j = 25°C		62	69	—	dB
Short circuit current limit		I _{SC}	1	T _j = 25°C		—	960	—	mA
Dropout voltage		V _D	1	T _j = 25°C		—	1.7	—	V
Average temperature coefficient of output voltage		T _{CV0}	1	I _{OUT} = 5 mA		—	−0.6	—	mV/°C

TA78M06SB
Electrical Characteristics

(Unless otherwise specified, $V_{IN} = 11\text{ V}$, $I_{OUT} = 350\text{ mA}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$)

Characteristics		Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage		V _{OUT}	1	T _j = 25°C		5.75	6.0	6.25	V
Line regulation		Reg-line	1	T _j = 25°C	8 V ≤ V _{IN} ≤ 25 V, I _{OUT} = 200 mA	—	4	100	mV
					9 V ≤ V _{IN} ≤ 25 V, I _{OUT} = 200 mA	—	2	50	
Load regulation		Reg-load	1	T _j = 25°C	5 mA ≤ I _{OUT} ≤ 500 mA	—	25	120	mV
					5 mA ≤ I _{OUT} ≤ 200 mA	—	10	60	
Output voltage		V _{OUT}	1	T _j = 25°C	8 V ≤ V _{IN} ≤ 21 V, 5 mA ≤ I _{OUT} ≤ 350 mA	5.7	—	6.3	V
Quiescent current		I _B	1	T _j = 25°C		—	4.5	8.0	mA
Quiescent current change	Line	ΔI _{BI}	1	T _j = 25°C	9.5 V ≤ V _{IN} ≤ 25.5 V, I _{OUT} = 200 mA	—	—	0.8	mA
	Load	ΔI _{BO}	1		5 mA ≤ I _{OUT} ≤ 350 mA	—	—	0.5	
Output noise voltage		V _{NO}	2	Ta = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	55	220	μV _{rms}
Ripple rejection		R.R.	3	f = 120 Hz, I _{OUT} = 100 mA, 9 V ≤ V _{IN} ≤ 19 V, T _j = 25°C		59	66	—	dB
Short circuit current limit		I _{SC}	1	T _j = 25°C		—	960	—	mA
Dropout voltage		V _D	1	T _j = 25°C		—	1.7	—	V
Average temperature coefficient of output voltage		T _{CV0}	1	I _{OUT} = 5 mA		—	−0.7	—	mV/°C

TA78M08SB
Electrical Characteristics

(Unless otherwise specified, $V_{IN} = 14\text{ V}$, $I_{OUT} = 350\text{ mA}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$)

Characteristics		Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage		V _{OUT}	1	T _j = 25°C		7.7	8.0	8.3	V
Line regulation	Reg-line	1	T _j = 25°C	10.5 V ≤ V _{IN} ≤ 25 V, I _{OUT} = 200 mA	—	5	100	mV	
				11 V ≤ V _{IN} ≤ 25 V, I _{OUT} = 200 mA	—	3	50		
Load regulation	Reg-load	1	T _j = 25°C	5 mA ≤ I _{OUT} ≤ 500 mA	—	26	160	mV	
				5 mA ≤ I _{OUT} ≤ 200 mA	—	10	80		
Output voltage		V _{OUT}	1	T _j = 25°C	10.5 V ≤ V _{IN} ≤ 23 V, 5 mA ≤ I _{OUT} ≤ 350 mA	7.6	—	8.4	V
Quiescent current		I _B	1	T _j = 25°C		—	4.6	8.0	mA
Quiescent current change	Line	ΔI _{BI}	1	T _j = 25°C	11 V ≤ V _{IN} ≤ 25.5 V, I _{OUT} = 200 mA	—	—	0.8	mA
	Load	ΔI _{BO}	1		5 mA ≤ I _{OUT} ≤ 350 mA	—	—	0.5	
Output noise voltage		V _{NO}	2	T _a = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	60	250	μV _{rms}
Ripple rejection		R.R.	3	f = 120 Hz, I _{OUT} = 100 mA, 11.5 V ≤ V _{IN} ≤ 21.5 V, T _j = 25°C		56	63	—	dB
Short circuit current limit		I _{SC}	1	T _j = 25°C		—	960	—	mA
Dropout voltage		V _D	1	T _j = 25°C		—	1.7	—	V
Average temperature coefficient of output voltage		T _{CV0}	1	I _{OUT} = 5 mA		—	−1.0	—	mV/°C

TA78M09SB
Electrical Characteristics

(Unless otherwise specified, $V_{IN} = 15\text{ V}$, $I_{OUT} = 350\text{ mA}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$)

Characteristics		Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage		V _{OUT}	1	T _j = 25°C		8.64	9.0	9.36	V
Line regulation	Reg-line	1	T _j = 25°C	11.5 V ≤ V _{IN} ≤ 26 V, I _{OUT} = 200 mA	—	5	100	mV	
				13 V ≤ V _{IN} ≤ 26 V, I _{OUT} = 200 mA	—	3	50		
Load regulation	Reg-load	1	T _j = 25°C	5 mA ≤ I _{OUT} ≤ 500 mA	—	26	180	mV	
				5 mA ≤ I _{OUT} ≤ 200 mA	—	10	90		
Output voltage		V _{OUT}	1	T _j = 25°C	11.5 V ≤ V _{IN} ≤ 24 V, 5 mA ≤ I _{OUT} ≤ 350 mA	8.55	—	9.45	V
Quiescent current		I _B	1	T _j = 25°C		—	4.6	8.0	mA
Quiescent current change	Line	ΔI _{BI}	1	T _j = 25°C	12 V ≤ V _{IN} ≤ 26.5 V, I _{OUT} = 200 mA	—	—	0.8	mA
	Load	ΔI _{BO}	1		5 mA ≤ I _{OUT} ≤ 350 mA	—	—	0.5	
Output noise voltage		V _{NO}	2	Ta = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	60	270	μV _{rms}
Ripple rejection		R.R.	3	f = 120 Hz, I _{OUT} = 100 mA, 12.5 V ≤ V _{IN} ≤ 22.5 V, T _j = 25°C		56	63	—	dB
Short circuit current limit		I _{SC}	1	T _j = 25°C		—	960	—	mA
Dropout voltage		V _D	1	T _j = 25°C		—	1.7	—	V
Average temperature coefficient of output voltage		T _{CV0}	1	I _{OUT} = 5 mA		—	−1.1	—	mV/°C

TA78M10SB
Electrical Characteristics

(Unless otherwise specified, $V_{IN} = 16\text{ V}$, $I_{OUT} = 350\text{ mA}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$)

Characteristics		Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage		V _{OUT}	1	T _j = 25°C		9.6	10.0	10.4	V
Line regulation	Reg-line	1	T _j = 25°C	12.5 V ≤ V _{IN} ≤ 26 V, I _{OUT} = 200 mA	—	6	100	mV	
				14 V ≤ V _{IN} ≤ 26 V, I _{OUT} = 200 mA	—	3	50		
Load regulation	Reg-load	1	T _j = 25°C	5 mA ≤ I _{OUT} ≤ 500 mA	—	26	200	mV	
				5 mA ≤ I _{OUT} ≤ 200 mA	—	10	100		
Output voltage		V _{OUT}	1	T _j = 25°C	12.5 V ≤ V _{IN} ≤ 25 V, 5 mA ≤ I _{OUT} ≤ 350 mA	9.5	—	10.5	V
Quiescent current		I _B	1	T _j = 25°C		—	4.7	8.0	mA
Quiescent current change	Line	ΔI _{BI}	1	T _j = 25°C	13 V ≤ V _{IN} ≤ 26.5 V, I _{OUT} = 200 mA	—	—	0.8	mA
	Load	ΔI _{BO}	1		5 mA ≤ I _{OUT} ≤ 350 mA	—	—	0.5	
Output noise voltage		V _{NO}	2	Ta = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	65	280	μV _{rms}
Ripple rejection		R.R.	3	f = 120 Hz, I _{OUT} = 100 mA, 13.5 V ≤ V _{IN} ≤ 23.5 V, T _j = 25°C		55	62	—	dB
Short circuit current limit		I _{SC}	1	T _j = 25°C		—	960	—	mA
Dropout voltage		V _D	1	T _j = 25°C		—	1.7	—	V
Average temperature coefficient of output voltage		T _{CV0}	1	I _{OUT} = 5 mA		—	−1.3	—	mV/°C

TA78M12SB
Electrical Characteristics

(Unless otherwise specified, $V_{IN} = 19\text{ V}$, $I_{OUT} = 350\text{ mA}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$)

Characteristics		Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage		V _{OUT}	1	T _j = 25°C		11.5	12.0	12.5	V
Line regulation	Reg-line	1	T _j = 25°C	14.5 V ≤ V _{IN} ≤ 30 V, I _{OUT} = 200 mA	—	7	100	mV	
				16 V ≤ V _{IN} ≤ 30 V, I _{OUT} = 200 mA	—	3	50		
Load regulation	Reg-load	1	T _j = 25°C	5 mA ≤ I _{OUT} ≤ 500 mA	—	27	240	mV	
				5 mA ≤ I _{OUT} ≤ 200 mA	—	10	120		
Output voltage		V _{OUT}	1	T _j = 25°C	14.5 V ≤ V _{IN} ≤ 27 V, 5 mA ≤ I _{OUT} ≤ 350 mA	11.4	—	12.6	V
Quiescent current		I _B	1	T _j = 25°C		—	4.8	8.0	mA
Quiescent current change	Line	ΔI _{BI}	1	T _j = 25°C	15 V ≤ V _{IN} ≤ 30.5 V, I _{OUT} = 200 mA	—	—	0.8	mA
	Load	ΔI _{BO}	1		5 mA ≤ I _{OUT} ≤ 350 mA	—	—	0.5	
Output noise voltage		V _{NO}	2	T _a = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	70	300	μV _{rms}
Ripple rejection		R.R.	3	f = 120 Hz, I _{OUT} = 100 mA, 15 V ≤ V _{IN} ≤ 25 V, T _j = 25°C		55	62	—	dB
Short circuit current limit		I _{SC}	1	T _j = 25°C		—	960	—	mA
Dropout voltage		V _D	1	T _j = 25°C		—	1.7	—	V
Average temperature coefficient of output voltage		T _{CV0}	1	I _{OUT} = 5 mA		—	−1.6	—	mV/°C

TA78M15SB
Electrical Characteristics

(Unless otherwise specified, $V_{IN} = 23\text{ V}$, $I_{OUT} = 350\text{ mA}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$)

Characteristics		Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage		V _{OUT}	1	T _j = 25°C		14.4	15.0	15.6	V
Line regulation	Reg-line	1	T _j = 25°C	17.5 V ≤ V _{IN} ≤ 30 V, I _{OUT} = 200 mA	—	8	100	mV	
				20 V ≤ V _{IN} ≤ 30 V, I _{OUT} = 200 mA	—	4	50		
Load regulation	Reg-load	1	T _j = 25°C	5 mA ≤ I _{OUT} ≤ 500 mA	—	27	300	mV	
				5 mA ≤ I _{OUT} ≤ 200 mA	—	10	150		
Output voltage		V _{OUT}	1	T _j = 25°C	17.5 V ≤ V _{IN} ≤ 30 V, 5 mA ≤ I _{OUT} ≤ 350 mA	14.25	—	15.75	V
Quiescent current		I _B	1	T _j = 25°C		—	4.8	8.0	mA
Quiescent current change	Line	ΔI _{BI}	1	T _j = 25°C	18 V ≤ V _{IN} ≤ 30.5 V, I _{OUT} = 200 mA	—	—	0.8	mA
	Load	ΔI _{BO}	1		5 mA ≤ I _{OUT} ≤ 350 mA	—	—	0.5	
Output noise voltage		V _{NO}	2	T _a = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	80	450	μV _{rms}
Ripple rejection		R.R.	3	f = 120 Hz, I _{OUT} = 100 mA, 18.5 V ≤ V _{IN} ≤ 28.5 V, T _j = 25°C		54	61	—	dB
Short circuit current limit		I _{SC}	1	T _j = 25°C		—	960	—	mA
Dropout voltage		V _D	1	T _j = 25°C		—	1.7	—	V
Average temperature coefficient of output voltage		T _{CV0}	1	I _{OUT} = 5 mA		—	−2.0	—	mV/°C

TA78M18SB
Electrical Characteristics

(Unless otherwise specified, $V_{IN} = 27\text{ V}$, $I_{OUT} = 350\text{ mA}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$)

Characteristics		Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage		V _{OUT}	1	T _j = 25°C		17.3	18.0	18.7	V
Line regulation	Reg-line	1	T _j = 25°C	21 V ≤ V _{IN} ≤ 33 V, I _{OUT} = 200 mA	—	9	100	mV	
				24 V ≤ V _{IN} ≤ 33 V, I _{OUT} = 200 mA	—	5	50		
Load regulation	Reg-load	1	T _j = 25°C	5 mA ≤ I _{OUT} ≤ 500 mA	—	28	360	mV	
				5 mA ≤ I _{OUT} ≤ 200 mA	—	10	180		
Output voltage		V _{OUT}	1	T _j = 25°C	21 V ≤ V _{IN} ≤ 33 V, 5 mA ≤ I _{OUT} ≤ 350 mA	17.1	—	18.9	V
Quiescent current		I _B	1	T _j = 25°C		—	4.8	8.0	mA
Quiescent current change	Line	ΔI _{BI}	1	T _j = 25°C	21.5 V ≤ V _{IN} ≤ 33.5 V, I _{OUT} = 200 mA	—	—	0.8	mA
	Load	ΔI _{BO}	1		5 mA ≤ I _{OUT} ≤ 350 mA	—	—	0.5	
Output noise voltage		V _{NO}	2	Ta = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	90	490	μV _{rms}
Ripple rejection		R.R.	3	f = 120 Hz, I _{OUT} = 100 mA, 22 V ≤ V _{IN} ≤ 32 V, T _j = 25°C		53	60	—	dB
Short circuit current limit		I _{SC}	1	T _j = 25°C		—	960	—	mA
Dropout voltage		V _D	1	T _j = 25°C		—	1.7	—	V
Average temperature coefficient of output voltage		T _{CV0}	1	I _{OUT} = 5 mA		—	−2.5	—	mV/°C

TA78M20SB
Electrical Characteristics

(Unless otherwise specified, $V_{IN} = 29\text{ V}$, $I_{OUT} = 350\text{ mA}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$)

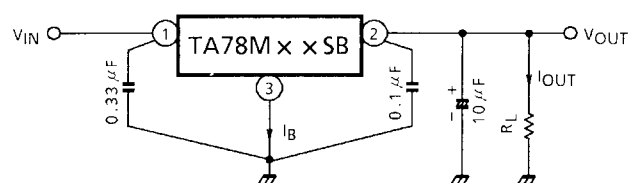
Characteristics		Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage		V _{OUT}	1	T _j = 25°C		19.2	20.0	20.8	V
Line regulation		Reg-line	1	T _j = 25°C	23 V ≤ V _{IN} ≤ 35 V, I _{OUT} = 200 mA	—	10	100	mV
					24 V ≤ V _{IN} ≤ 35 V, I _{OUT} = 200 mA	—	6	50	
Load regulation		Reg-load	1	T _j = 25°C	5 mA ≤ I _{OUT} ≤ 500 mA	—	28	400	mV
					5 mA ≤ I _{OUT} ≤ 200 mA	—	10	200	
Output voltage		V _{OUT}	1	T _j = 25°C	23 V ≤ V _{IN} ≤ 35 V, 5 mA ≤ I _{OUT} ≤ 350 mA	19.0	—	21.0	V
Quiescent current		I _B	1	T _j = 25°C		—	4.9	8.0	mA
Quiescent current change	Line	ΔI _{BI}	1	T _j = 25°C	23.5 V ≤ V _{IN} ≤ 35.5 V, I _{OUT} = 200 mA	—	—	0.8	mA
	Load	ΔI _{BO}	1		5 mA ≤ I _{OUT} ≤ 350 mA	—	—	0.5	
Output noise voltage		V _{NO}	2	T _a = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	95	540	μV _{rms}
Ripple rejection		R.R.	3	f = 120 Hz, I _{OUT} = 100 mA, 24 V ≤ V _{IN} ≤ 34 V, T _j = 25°C		53	60	—	dB
Short circuit current limit		I _{SC}	1	T _j = 25°C		—	960	—	mA
Dropout voltage		V _D	1	T _j = 25°C		—	1.7	—	V
Average temperature coefficient of output voltage		T _{CV0}	1	I _{OUT} = 5 mA		—	−3.0	—	mV/°C

TA78M24SB
Electrical Characteristics

(Unless otherwise specified, $V_{IN} = 33\text{ V}$, $I_{OUT} = 350\text{ mA}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$)

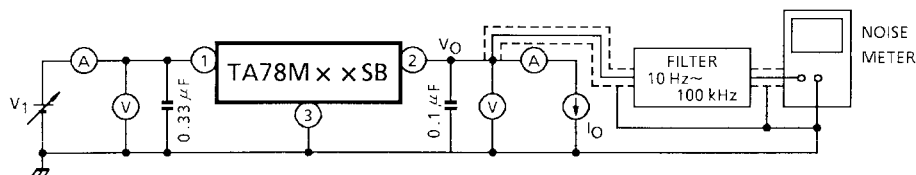
Characteristics		Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage		V _{OUT}	1	T _j = 25°C		23.0	24.0	25.0	V
Line regulation	Reg-line	1	T _j = 25°C	27 V ≤ V _{IN} ≤ 38 V, I _{OUT} = 200 mA	—	12	100	mV	
				28 V ≤ V _{IN} ≤ 38 V, I _{OUT} = 200 mA	—	7	50		
Load regulation	Reg-load	1	T _j = 25°C	5 mA ≤ I _{OUT} ≤ 500 mA	—	30	480	mV	
				5 mA ≤ I _{OUT} ≤ 200 mA	—	10	240		
Output voltage		V _{OUT}	1	T _j = 25°C	27 V ≤ V _{IN} ≤ 38 V, 5 mA ≤ I _{OUT} ≤ 350 mA	22.8	—	25.2	V
Quiescent current		I _B	1	T _j = 25°C		—	5.0	8.0	mA
Quiescent current change	Line	ΔI _{BI}	1	T _j = 25°C	27.5 V ≤ V _{IN} ≤ 38.5 V, I _{OUT} = 200 mA	—	—	0.8	mA
	Load	ΔI _{BO}	1		5 mA ≤ I _{OUT} ≤ 350 mA	—	—	0.5	
Output noise voltage		V _{NO}	2	T _a = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	115	650	μV _{rms}
Ripple rejection		R.R.	3	f = 120 Hz, I _{OUT} = 100 mA, 28 V ≤ V _{IN} ≤ 38 V, T _j = 25°C		50	57	—	dB
Short circuit current limit		I _{SC}	1	T _j = 25°C		—	960	—	mA
Dropout voltage		V _D	1	T _j = 25°C		—	1.7	—	V
Average temperature coefficient of output voltage		T _{CV0}	1	I _{OUT} = 5 mA		—	−3.5	—	mV/°C

Test Circuit 1/Standard Application



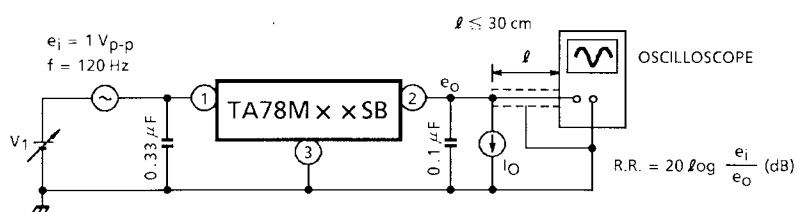
Test Circuit 2

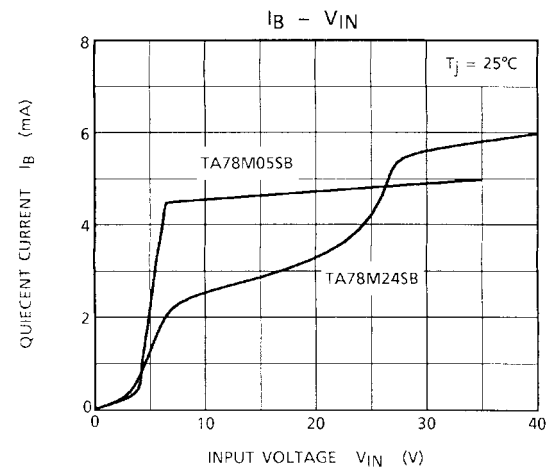
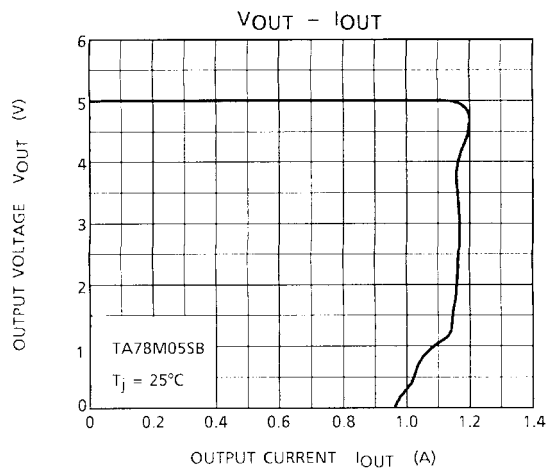
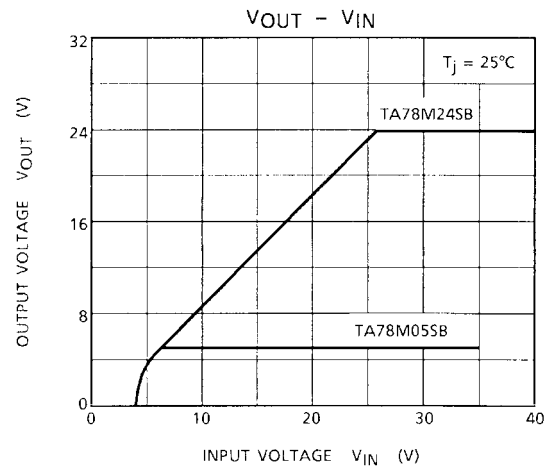
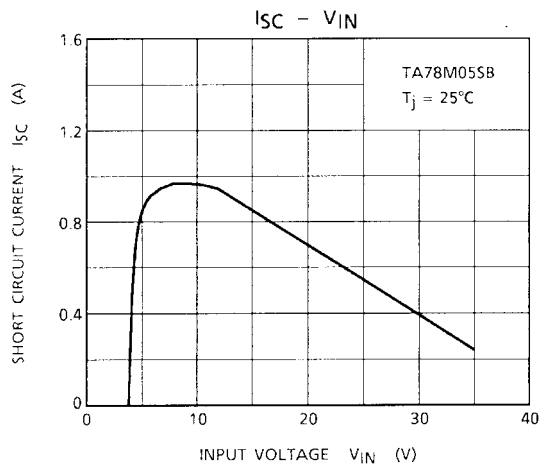
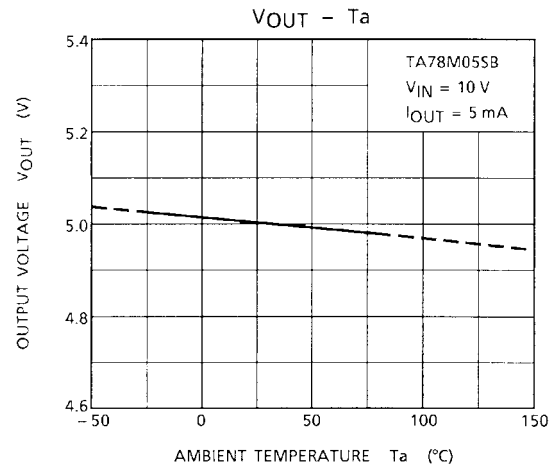
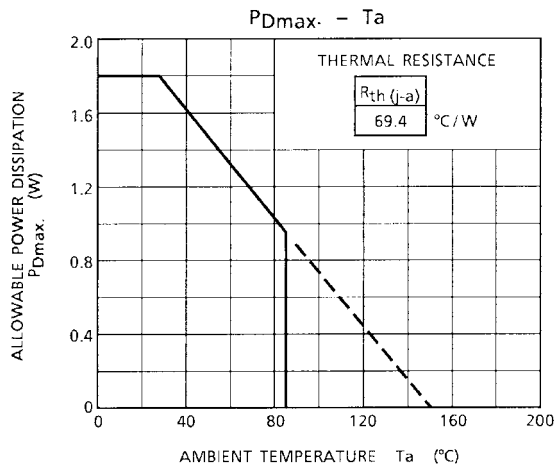
V_{NO}

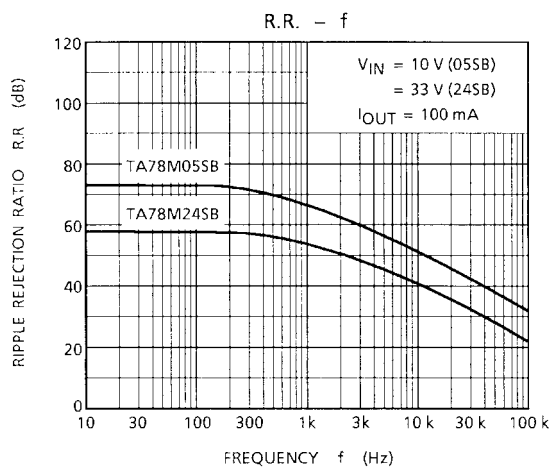
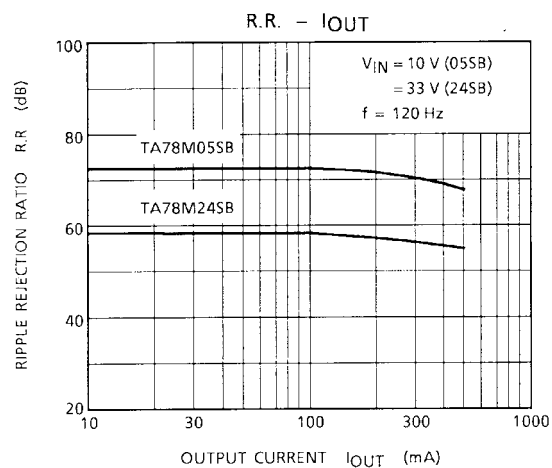
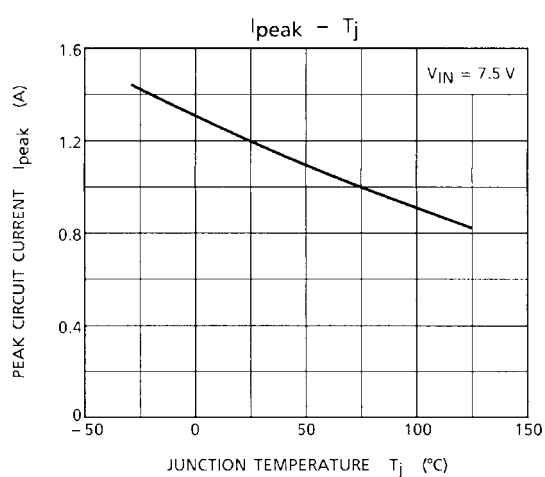
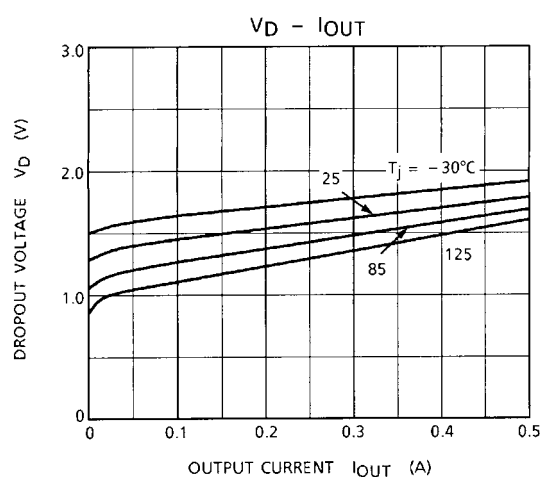


Test Circuit 3

R.R.

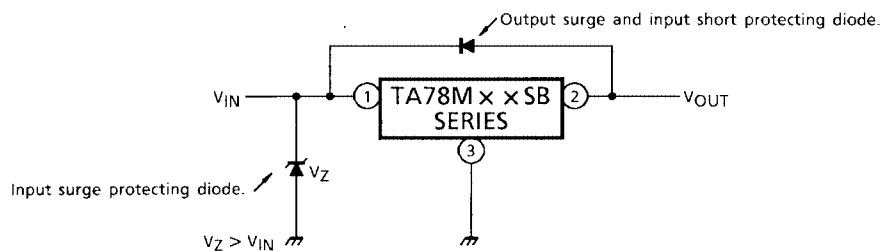




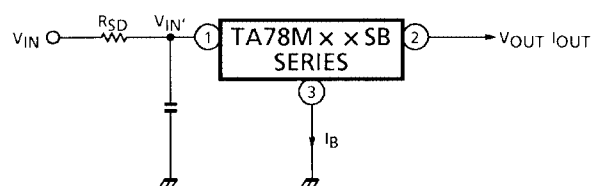


Precautions on Application

- (1) In regard to GND, be careful not to apply a negative voltage to the input/output terminal. Further, special care is necessary in case of a voltage boost application.
- (2) When a surge voltage exceeding maximum rating is applied to the input terminal or when a voltage in excess of the input terminal voltage is applied to the output terminal, the circuit may be destroyed. Specially, in the latter case, great care is necessary.
Further, if the input terminal sorts to GND in a state of normal operation, the output terminal voltage becomes higher than the input voltage (GND potential), and the electric charge of a chemical capacitor connected to the output terminal flows into the input side, which may cause the destruction of circuit.
In these cases, take such steps as a zener diode and a general silicon diode are connected to the circuit, as shown in the following figure.



- (3) When the input voltage is too high, the power dissipation of three terminal regulator increases because of series regulator, so that the junction temperature rises. In such a case, it is recommended to reduce the power dissipation by inserting the power limiting resistor R_{SD} in the input terminal, and to reduce the junction temperature as a result.



The power dissipation P_D of IC is expressed in the following equation.

$$P_D = (V_{IN}' - V_{OUT}) \cdot I_{OUT} + V_{IN}' \cdot I_B$$

If V_{IN}' is reduced below the lowest voltage necessary for the IC, the parasitic oscillation will be caused according to circumstances.

In determining the resistance value of R_{SD} , design with margin should be made by making reference to the following equation.

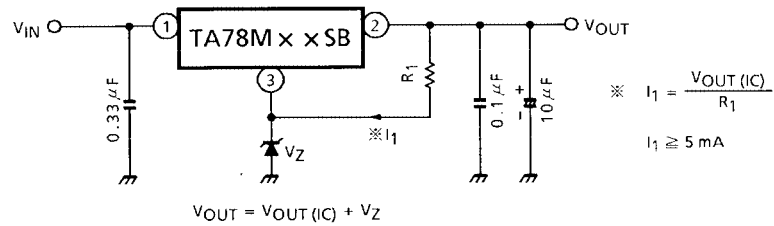
$$R_{SD} < \frac{V_{IN} - V_{IN}'}{I_{OUT} + I_B}$$

- (4) Connect the input terminal and GND, and the output terminal and GND, by capacitor respectively. The capacitances should be determined experimentally because they depend on printed circuit board patterns. In particular, adequate investigation should be made so that there is no problem even at time of high or low temperature.

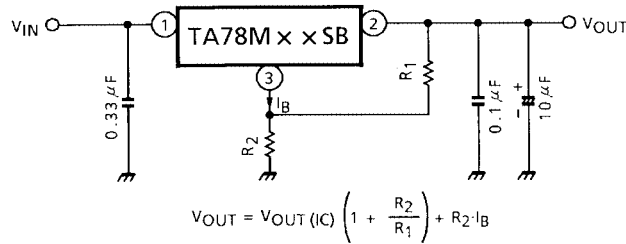
Application Circuits

(1) Voltage Boost Regulator

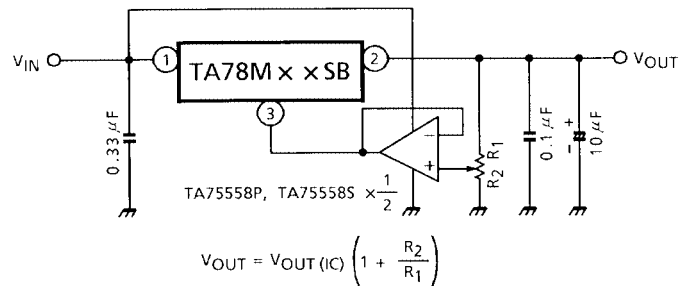
(a) Voltage boost by use of zener diode



(b) Voltage boost by use of resistor

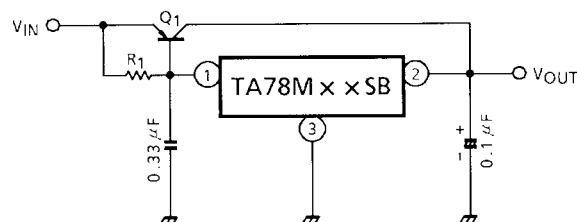


(c) Adjustable output regulator



(2) Current Boost Regulator

(a) Current boost voltage regulator



Heat sink is needed for Q1

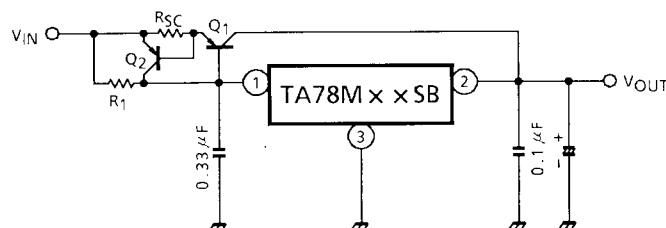
$$R_1 \leq \frac{V_{BE1}}{I_B \text{ MAX}}$$

where,

V_{BE1} : V_{BE} of external transistor Q1.

$I_B \text{ MAX}$: Quiescent current of IC.

(b) Short.circuit protection

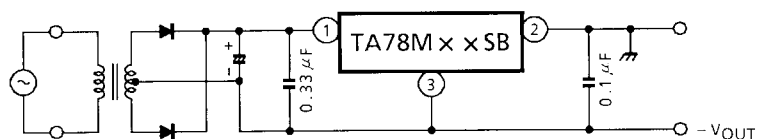


$$R_{SC} = \frac{V_{BE2}}{I_{SC}}$$

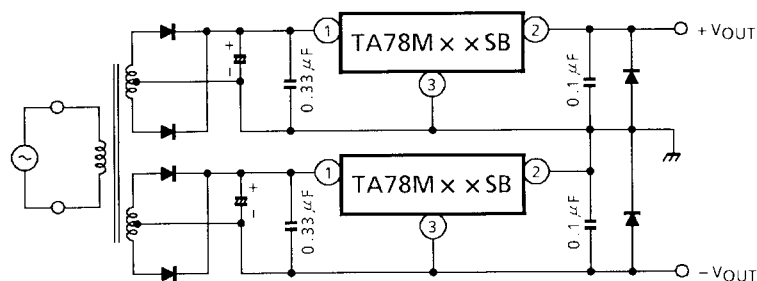
where,

I_{SC} : Short-circuit current

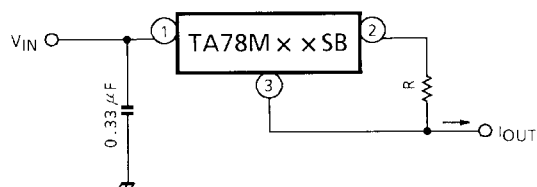
(3) Negative Regulator



(4) Positive and Negative Regulator



(5) Current Regulator

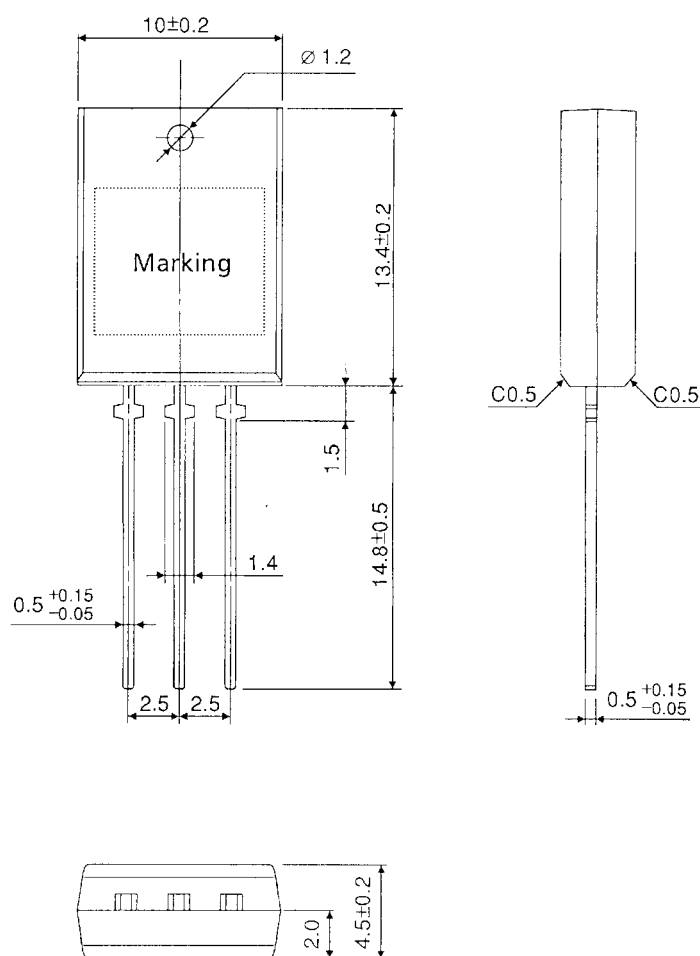


$$I_{OUT} = \frac{V_{OUT}}{R} + I_B$$

Package Dimensions

SIP3-P-2.50A

Unit : mm



Weight : 1.5 g (Typ.)

RESTRICTIONS ON PRODUCT USE

000707EBA

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